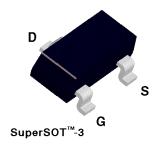
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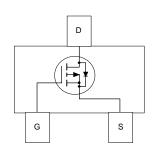
General Description

SuperSOT™-3 P-Channel logic level enhancement mode power field effect transistors are produced using Fairchild's proprietary, high cell density, DMOS technology. This very high density process is especially tailored to minimize on-state resistance. These devices are particularly suited for low voltage applications such as notebook computer power management, portable electronics, and other battery powered circuits where fast high-side switching, and low in-line power loss are needed in a very small outline surface mount package.

Features

- -1.1 A, -30 V, $R_{DS(ON)} = 0.3 \Omega$ @ V_{GS} =-4.5 V $R_{DS(ON)} = 0.2 \Omega$ @ V_{GS} =-10 V.
- Industry standard outline SOT-23 surface mount package using proprietary SuperSOTTM-3 design for superior thermal and electrical capabilities.
- High density cell design for extremely low R_{DS(ON)}.
- Exceptional on-resistance and maximum DC current capability.





Absolute Maximum Ratings T_A = 25°C unless otherwise noted

Symbol	Parameter	NDS356AP	Units
V _{DSS}	Drain-Source Voltage	-30	V
V_{GSS}	Gate-Source Voltage - Continuous	±20	V
D	Maximum Drain Current - Continuous (Note 1a)	±1.1	А
	- Pulsed	±10	
$P_{\scriptscriptstyle D}$	Maximum Power Dissipation (Note 1a)	0.5	W
	(Note 1b)	0.46	
T_J , T_{STG}	Operating and Storage Temperature Range	-55 to 150	°C
THERMA	L CHARACTERISTICS		
R _{øJA}	Thermal Resistance, Junction-to-Ambient (Note 1a)	250	°C/W
R _{euc}	Thermal Resistance, Junction-to-Case (Note 1)	75	°C/W



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Symbol	Parameter	Conditions		Min	Тур	Max	Units
OFF CHA	RACTERISTICS						•
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_{D} = -250 \mu\text{A}$		-30			V
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = -24 \text{ V}, \ V_{GS} = 0 \text{ V}$				-1	μA
			T _J =55°C			-10	μA
GSSF	Gate - Body Leakage, Forward	$V_{GS} = 20 \text{ V}, V_{DS} = 0 \text{ V}$	•			100	nA
I _{GSSR}	Gate - Body Leakage, Reverse	$V_{GS} = -20V, V_{DS} = 0 V$				-100	nA
ON CHAR	ACTERISTICS (Note 2)						•
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}$, $I_D = -250 \mu A$ $T_J = 12$		-0.8	-1.6	-2.5	V
			T _J =125°C	-0.5	-1.3	-2.2	
R _{DS(ON)}	Static Drain-Source On-Resistance	$V_{GS} = -4.5 \text{ V}, I_D = -1.1 \text{ A}$	·		0.25	0.3	Ω
			T _J =125°C		0.35	0.4	
		$V_{GS} = -10 \text{ V}, I_{D} = -1.3 \text{ A}$			0.14	0.2	
I _{D(ON)}	On-State Drain Current	$V_{GS} = -4.5 \text{ V}, \ V_{DS} = -5 \text{ V}$		-3			Α
9 _{FS}	Forward Transconductance	$V_{DS} = -5 \text{ V}, I_{D} = -1.1 \text{ A}$			2		S
DYNAMIC	CHARACTERISTICS	-				I.	
C _{iss}	Input Capacitance	$V_{DS} = -10 \text{ V}, \ V_{GS} = 0 \text{ V},$			280		pF
C _{oss}	Output Capacitance	f = 1.0 MHz			170		pF
C _{rss}	Reverse Transfer Capacitance				65		pF
SWITCHIN	IG CHARACTERISTICS (Note 2)	-				I.	
t _{D(on)}	Turn - On Delay Time	$V_{DD} = -10 \text{ V}, I_{D} = -1 \text{ A},$			8	15	ns
t,	Turn - On Rise Time	$V_{GS} = -10 \text{ V}, \ R_{GEN} = 50 \Omega$			17	30	ns
t _{D(off)}	Turn - Off Delay Time				53	90	ns
t,	Turn - Off Fall Time				38	80	ns
Q_g	Total Gate Charge	$V_{DS} = -10 \text{ V}, I_{D} = -1.1 \text{ A},$			3.4	4.4	nC
Q_{gs}	Gate-Source Charge	V _{GS} = -5 V			0.7		nC
Q_{gd}	Gate-Drain Charge				1.5		nC



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Electrical Characteristics (T _A = 25°C unless otherwise noted)								
Symbol	Parameter	Conditions	Min	Тур	Max	Units		
DRAIN-SOURCE DIODE CHARACTERISTICS AND MAXIMUM RATINGS								
I _s	Maximum Continuous Source Current				-0.42	Α		
I _{SM}	Maximum Pulsed Drain-Source Diode Forward Current				-10	Α		
V_{SD}	Drain-Source Diode Forward Voltage	$V_{GS} = 0 \text{ V}, \ I_S = -0.42 \text{ (Note 2)}$		-0.8	-1.2	V		

Notes:

TAULES.

1. R_{But} is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. R_{But} is guaranteed by design while R_{But} is determined by the user's board design.

$$P_D(t) = \frac{T_J - T_A}{R_{\theta JA}(t)} = \frac{T_J - T_A}{R_{\theta JC} + R_{\theta CA}(t)} = I_D^2(t) \times R_{DS(ON)@T_J}$$

Typical R_{8.14} using the board layouts shown below on 4.5"x5" FR-4 PCB in a still air environment:

a. 250°C/W when mounted on a $0.02~\text{in}^2$ pad of 2oz copper.

b. 270°C/W when mounted on a 0.001 in² pad of 2oz copper.





Scale 1 : 1 on letter size paper 2. Pulse Test: Pulse Width ≤ 300µs, Duty Cycle ≤ 2.0%.